## *In-situ* photoemission study of the room-temperature ferromagnetism in ZnGeP<sub>2</sub>: Mn

Y. Ishida\*, D. D. Sarma<sup>1</sup>, K. Okazaki, J. Okabayashi, A. Fujimori, G. A. Medvedkin<sup>2</sup>, T. Ishibashi<sup>3</sup>, and K.Sato<sup>3</sup>
Department of Physics, University of Tokyo, Tokyo 113-0033, Japan <sup>1</sup>SSCU, Indian Institute of Science, Bangalore 560-012, India <sup>2</sup>Ioffe Physico-Technical Institute, St. Petersburg 194021, Russia
<sup>3</sup>Tokyo University of Agriculture and Technology, Tokyo 183-8538, Japan

After the successful synthesis of III-V-based ferromagnetic diluted magnetic semiconductors (DMS or DFS), it is now crucial to increase the T<sub>C</sub> above the room temperature (RT) for practical applications. There are several reports of RT-DFS such as TiO<sub>2</sub>:Co, ZnO:Co, and ZnO:V. Among them is the intriguing report of the II-IV-V<sub>2</sub>-type Mn incorporated chalcopyrite semiconductors CdGeP2 and ZnGeP2, which show ferromagnetism above 350 K [1]. High concentration of Mn ions are incorporated in the surface region by depositing Mn on the surface of ZnGeP<sub>2</sub> single crystals annealed at 400°C. Chemical reaction and the composition in the densely Mn-deposited surface region are still to be clarified.

In order to study the chemical and electronic structures of ZnGeP<sub>2</sub>:Mn interface, we performed extensive in-situ photoemission measurements. Core-level and valence-band spectra were taken for various amounts of Mn deposition on the ZnGeP<sub>2</sub> surface. As the Mn was deposited, Zn signal quickly disappeared while the Ge and P were always present even after depositing the nominal Mn thickness of 500 A. The magnetization curve measured by SQUID for this 500 A Mn deposited surface showed a two component ferromagnetic behavior, one vanishing at 290 K, and the other showing ferromagnetism even above 375 K. The former component may be assigned to MnP ( $T_C = 290$ K), while the latter is attributed to some ternary compound(s) of Mn, Ge, and P.

The valence band spectra showed a prominent Mn 3p-3d resonant peak up to the nominal Mn thickness of 30 A, while the Mn  $M_{23}VV$  Auger decay replaced the resonant behavior for further Mn deposition (Fig. 1). A clear Fermi edge was observed after 10 A Mn deposition, and its intensity was enhanced for further Mn deposition up to 100 A, beyond which both the ratio of the core-level intensities and the valence-band feature drastically changed. This indicates successive transitions from a

DMS-like chemical state to other metallic compounds with Mn deposition on the ZnGeP<sub>2</sub>:Mn interface.



Fig. 1. Valence-band spectra of the nominal Mn thickness of 4, 8, 16, and 32 A in the Mn 3p-3d core excitation reigion. Every spectrum is normalized to the photon flux. The difference spectra are taken between on-resonance (hv = 51eV) and off-resonance (hv = 48eV). The difference spectra below 30 A Mn deposition represent the Mn 3d partial DOS. The vertical bars in (d) denote the Mn M<sub>23</sub>VV Auger peak.

- G. A. Medvedkin *et. al.*, Jpn. J. Appl. Phys.**39**, L949 (2000)
- \* ishida@wyvern.phys.s.u-tokyo.ac.jp